## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10657441	JONES ET AL.
Examiner	Art Unit
Lay, Michelle K	2628

SEARCHED				
Class		Subclass	Date	Examine

SEARCH NOTES		
Search Notes	Date	Examiner
consulted with John Peng concerning 101 issues	02/14/2007	MKL

	INTERFERENCE SEAF	
Class	Subclass	Date Examin